



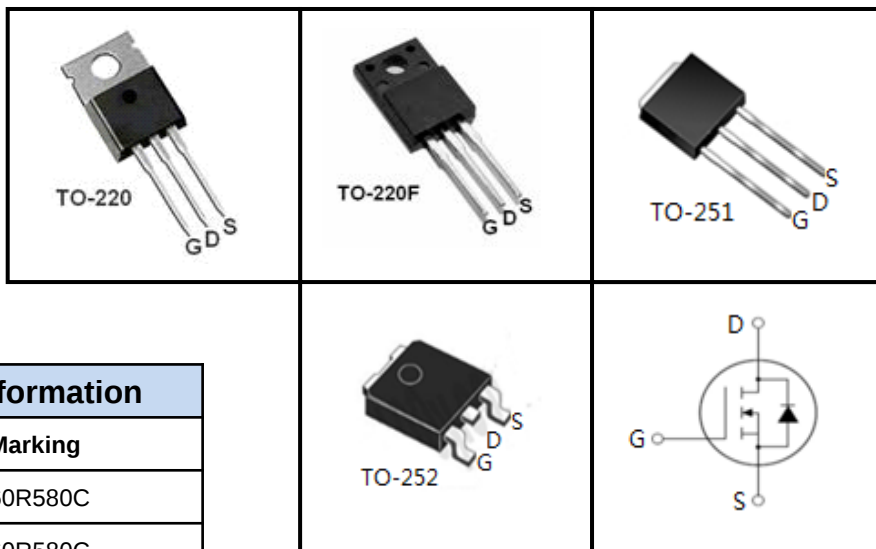
600V Super-Junction Power MOSFET

FEATURES

- Very low FOM $R_{DS(on)} \times Q_g$
- 100% avalanche tested
- RoHS compliant

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)



Device Marking and Package Information

Device	Package	Marking
TPP60R580C	TO-220	60R580C
TPA60R580C	TO-220F	60R580C
TPU60R580C	TO-251	60R580C
TPD60R580C	TO-252	60R580C

Absolute Maximum Ratings $T_C = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Value				Unit
		TO-220	TO-251	TO-252	TO-220F	
Drain-Source Voltage ($V_{GS} = 0V$)	V_{DSS}	600				V
Continuous Drain Current	I_D	7				A
Pulsed Drain Current (note1)	I_{DM}	21				A
Gate-Source Voltage	V_{GSS}	± 30				V
Single Pulse Avalanche Energy (note2)	E_{AS}	50				mJ
Avalanche Current (note1)	I_{AR}	7				A
Repetitive Avalanche Energy (note1)	E_{AR}	0.2				mJ
Power Dissipation ($T_C = 25^\circ\text{C}$)	P_D	63			28	W
Operating Junction and Storage Temperature Range	T_J, T_{stg}	$-55 \sim +150$				$^\circ\text{C}$

Thermal Resistance

Parameter	Symbol	Value				Unit
		TO-220	TO-251	TO-252	TO-220F	
Thermal Resistance, Junction-to-Case	R_{thJC}	2.0			4.5	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient	R_{thJA}	62			80	



Specifications T _J = 25°C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
Static						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	600	--	--	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 600V, V _{GS} = 0V, T _J = 25°C	--	--	1	μA
		V _{DS} = 600V, V _{GS} = 0V, T _J = 150°C	--	--	100	
Gate-Source Leakage	I _{GSS}	V _{GS} = ±30V	--	--	±100	nA
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	2.5	--	3.5	V
Drain-Source On-Resistance (Note3)	R _{DS(on)}	V _{GS} = 10V, I _D = 3A	--	0.50	0.58	Ω
Forward Transconductance (Note3)	g _{fs}	V _{DS} = 10V, I _D = 3A	--	5.6	--	S
Dynamic						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = 50V, f = 1.0MHz	--	486	--	pF
Output Capacitance	C _{oss}		--	68	--	
Reverse Transfer Capacitance	C _{rss}		--	4	--	
Total Gate Charge	Q _g	V _{DD} = 480V, I _D = 7A, V _{GS} = 10V	--	12	--	nC
Gate-Source Charge	Q _{gs}		--	2.5	--	
Gate-Drain Charge	Q _{gd}		--	4.5	--	
Turn-on Delay Time	t _{d(on)}	V _{DD} = 300V, I _D = 7A, R _G = 25Ω	--	14	31	ns
Turn-on Rise Time	t _r		--	32	66	
Turn-off Delay Time	t _{d(off)}		--	53	109	
Turn-off Fall Time	t _f		--	15	32	
Drain-Source Body Diode Characteristics						
Continuous Body Diode Current	I _S	T _C = 25°C	--	--	7	A
Pulsed Diode Forward Current	I _{SM}		--	--	21	
Body Diode Voltage	V _{SD}	T _J = 25°C, I _{SD} = 7A, V _{GS} = 0V	--	0.9	1.2	V
Reverse Recovery Time	t _{rr}	V _R = 480V, I _F = I _S , di _F /dt = 100A/μs	--	400	--	ns
Reverse Recovery Charge	Q _{rr}		--	1.5	--	μC
Peak Reverse Recovery Current	I _{rrm}		--	7	--	A

Notes

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. $I_{AS} = 3A, V_{DD} = 50V, R_G = 25\Omega$, Starting $T_J = 25^{\circ}\text{C}$
3. Pulse Test: Pulse width $\leq 300\mu s$, Duty Cycle $\leq 1\%$



Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

Figure 1. Output Characteristics

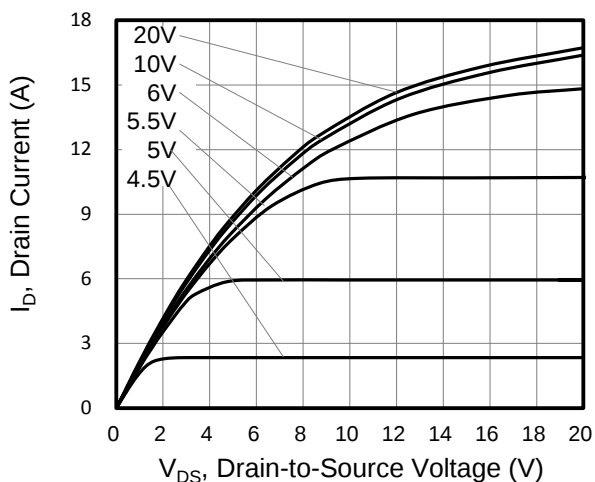


Figure 2. Transfer Characteristics

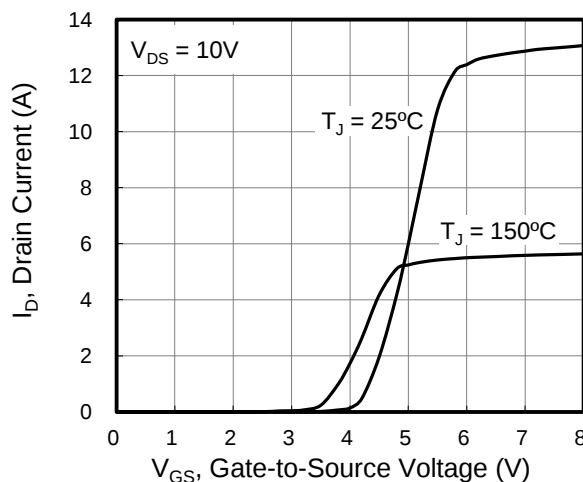


Figure 3. On-Resistance vs. Drain Current

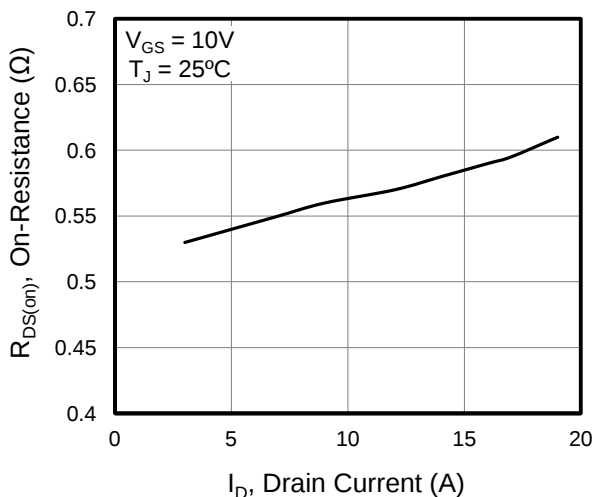


Figure 4. Capacitance

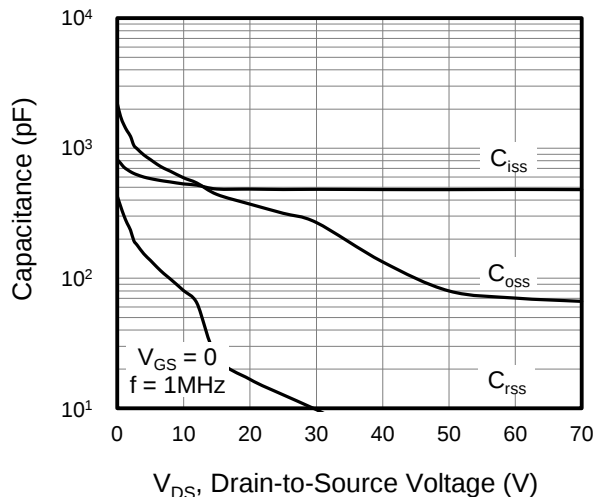


Figure 5. Gate Charge

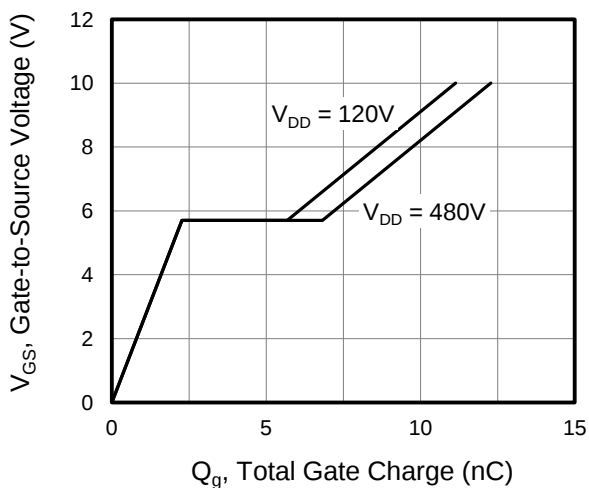
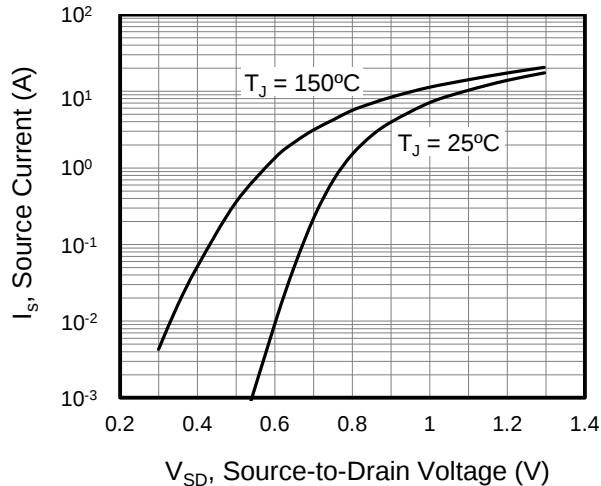


Figure 6. Body Diode Forward Voltage





Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

Figure 7. On-Resistance vs. Junction Temperature

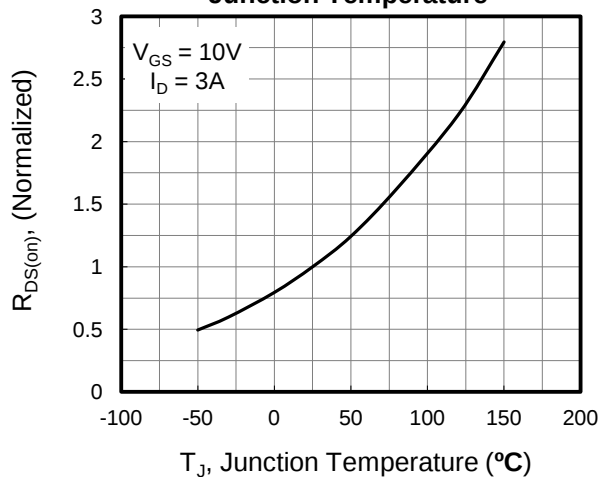


Figure 8. Threshold Voltage vs. Junction Temperature

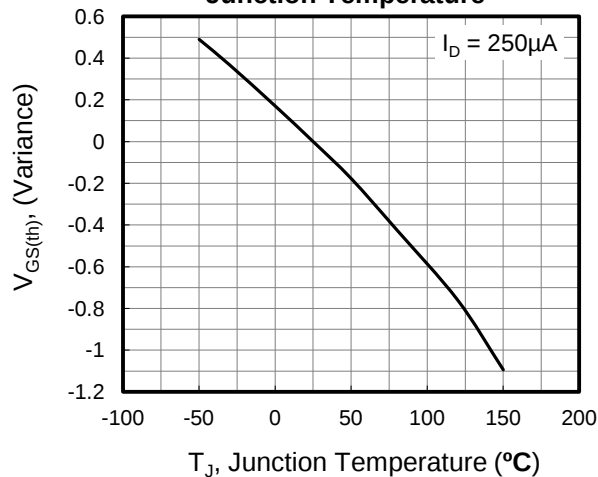


Figure 9. Transient Thermal Impedance TO-220/TO-251/TO-252

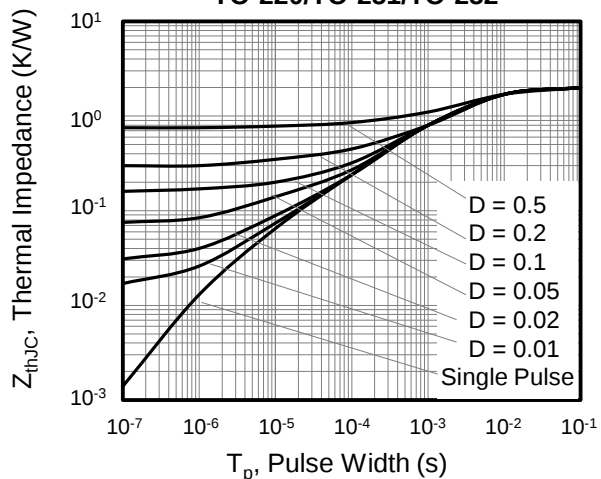


Figure 10. Transient Thermal Impedance TO-220F

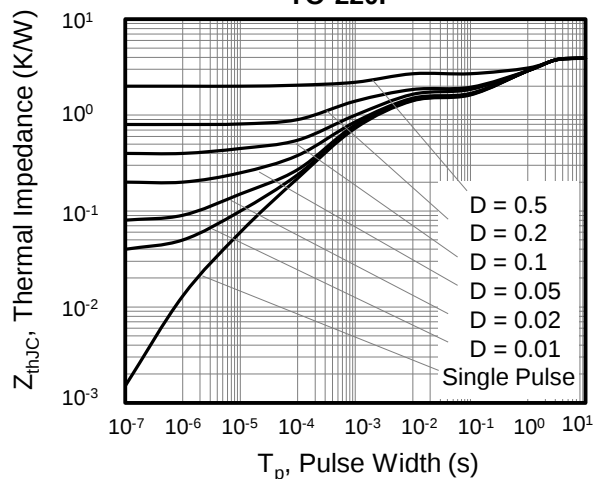


Figure 11. Safe Operating Area TO-220/TO-251/TO-252

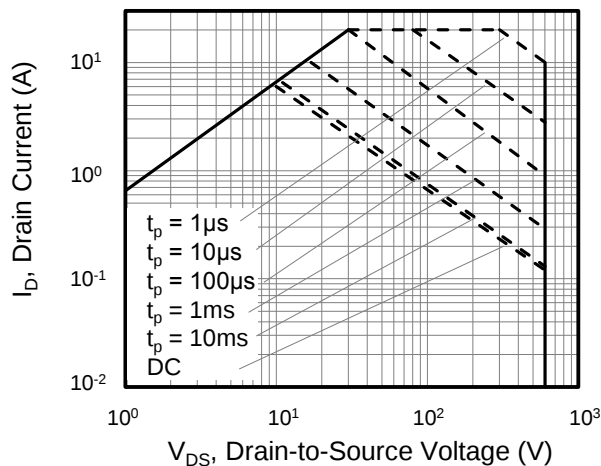


Figure 12. Safe Operating Area TO-220F

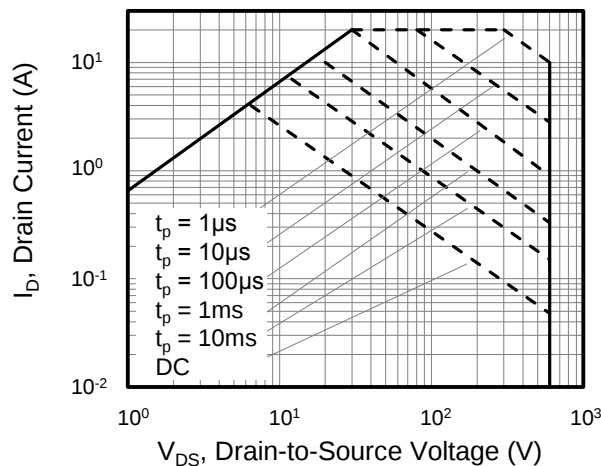




Figure A: Gate Charge Test Circuit and Waveform

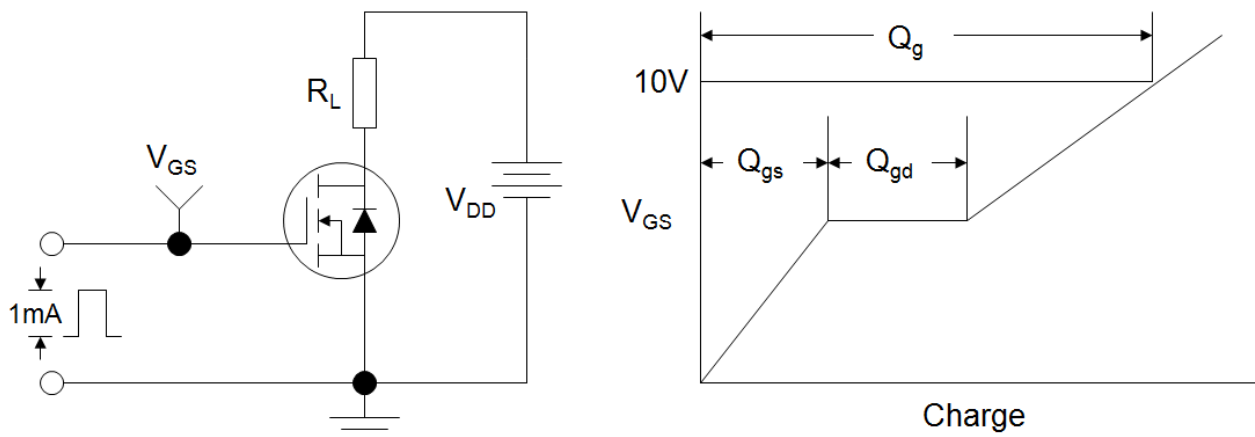


Figure B: Resistive Switching Test Circuit and Waveform

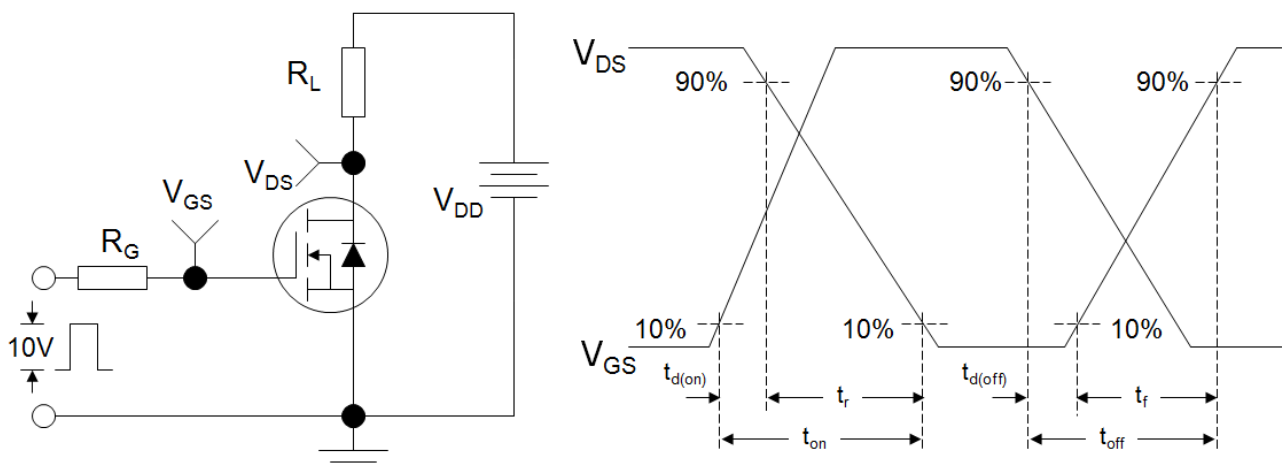
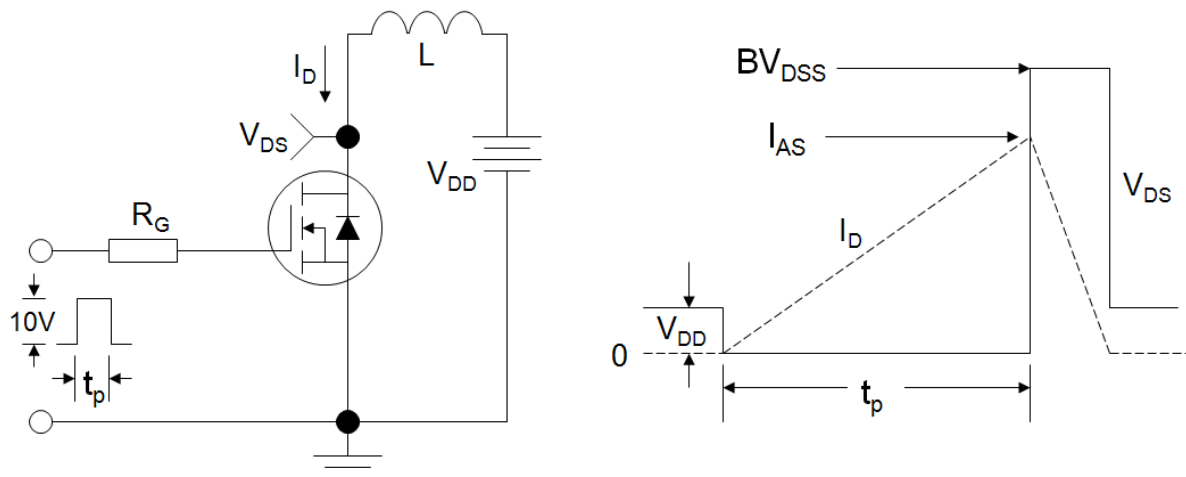


Figure C: Unclamped Inductive Switching Test Circuit and Waveform



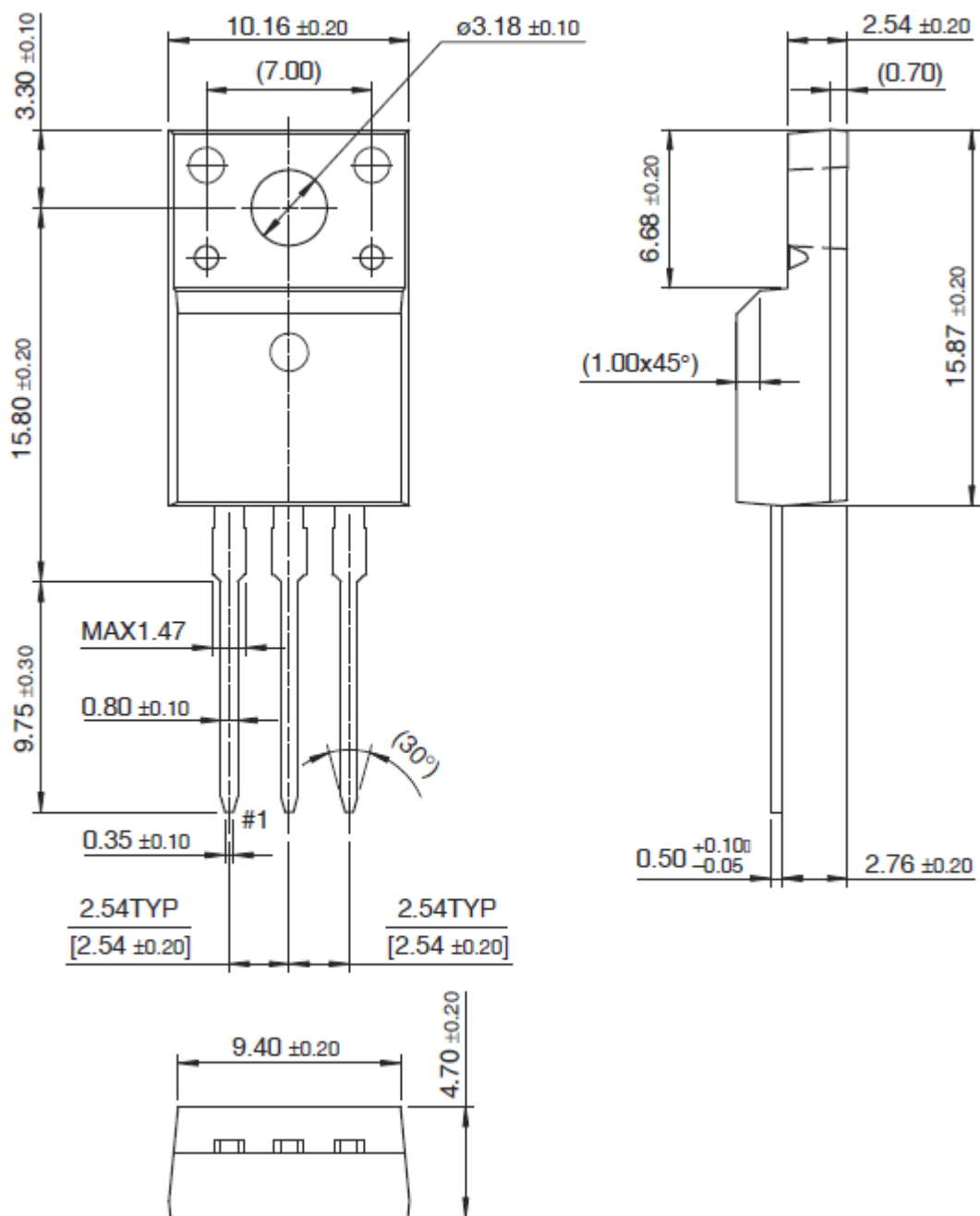


TO-220



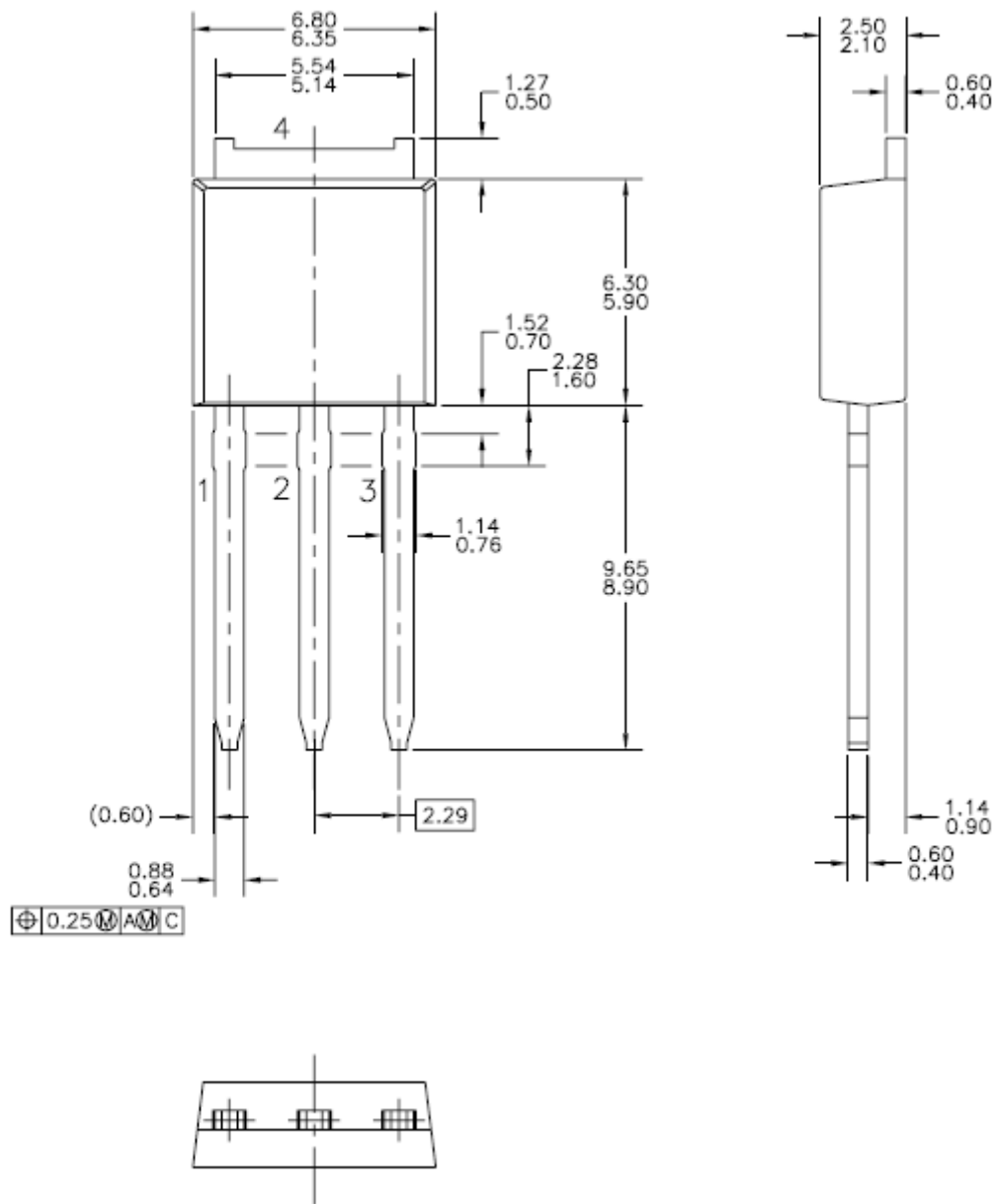


TO-220F





TO-251

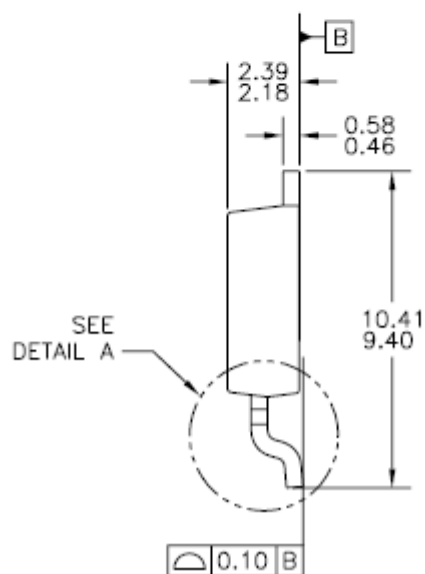
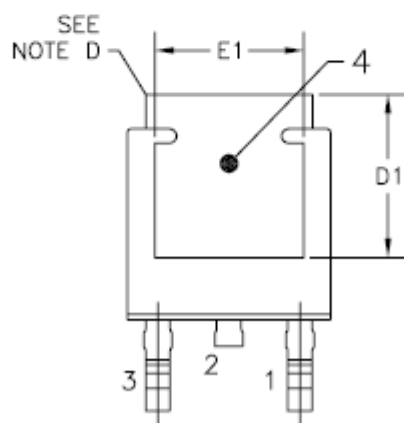




Wuxi Tongfang Microelectronics Company

Technical drawing of a rectangular component with dimensions and tolerances. The drawing shows a top view and a side view. The top view dimensions are: 6.73 (total width), 6.35 (width of the central section), 5.46 (width of the side sections), and 5.21 (width of the side sections). The side view dimensions are: D (total height), L3 (height of the side section), 1.02 MAX (height of the central section), 1.14 (height of the side sections), 0.76 (height of the side sections), 2.29 (height of the side sections), 4.57 (width of the side sections), 0.89 (width of the side sections), 0.64 (width of the side sections), and 0.59 (width of the side sections). The drawing includes a table of tolerances at the bottom left:

0.25	M	AM	C
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